

# PC900V/PC900VQ

## Digital Output Type OPIC Photocoupler

\* Lead forming type (I type) and taping reel type (P type) are also available. (PC900VI/PC900VP) (Page 656)  
 \*\* TÜV (DIN-VDE0884) approved type is also available as an option.

### ■ Features

1. High reliability type (PC900VQ)
  - ① Temperature cycling  
 Ta = -40°C (30 min.) → +125°C (30 min.), 10 cycles
  - ② High temperature storage  
 Ta = +125°C (20 hours)
2. Normal OFF operation, open collector output
3. TTL and LSTTL compatible output
4. Operating supply voltage V<sub>cc</sub> : 3 to 15V
5. High isolation voltage between input and output (V<sub>iso</sub> : 5 000V<sub>rms</sub>)
6. Recognized by UL, file No. E64380

### ■ Applications

1. Isolation between logic circuits
2. Logic level shifters
3. Line receivers
4. Replacements for relays and pulse transformers
5. Noise reduction

### ■ Absolute Maximum Ratings

(Ta = 25°C)

Parameter		Symbol	Rating	Unit
Input	Forward current	I <sub>F</sub>	50	mA
	*1 Peak forward current	I <sub>FM</sub>	1	A
	Reverse voltage	V <sub>R</sub>	6	V
	Power dissipation	P	70	mW
Output	Supply voltage	V <sub>cc</sub>	16	V
	High level output voltage	V <sub>OH</sub>	16	V
	Low level output current	I <sub>OL</sub>	50	mA
	Power dissipation	P <sub>O</sub>	150	mW
Total power dissipation		P <sub>tot</sub>	170	mW
*2 Isolation voltage		V <sub>iso</sub>	5 000	V <sub>rms</sub>
Operating temperature		T <sub>opr</sub>	-25 to +85	°C
Storage temperature		T <sub>stg</sub>	-40 to +125	°C
*3 Soldering temperature		T <sub>sol</sub>	260	°C

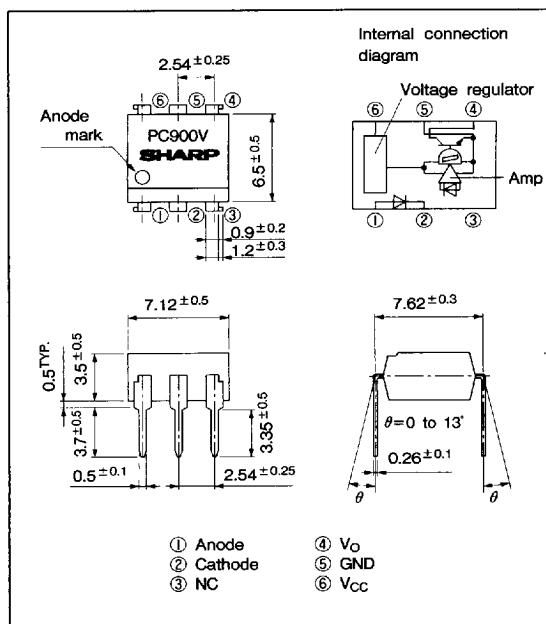
\*1 Pulse width ≤ 100 μs, Duty ratio = 0.001

\*2 40 to 60% RH, AC for 1 minute

\*3 For 10 seconds

### ■ Outline Dimensions

(Unit : mm)



\* "OPIC" (Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip.

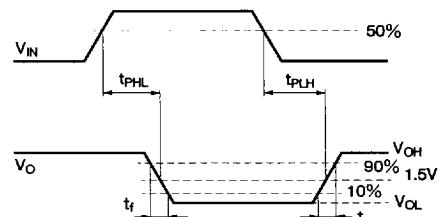
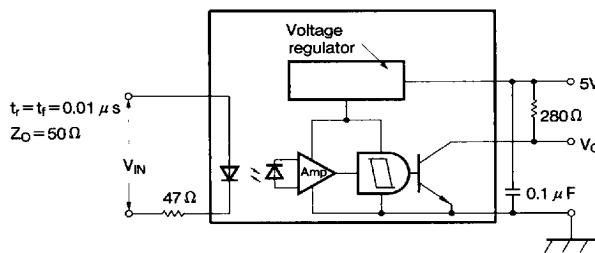
**■ Electro-optical Characteristics**

(Ta = 0 to +70°C unless specified)

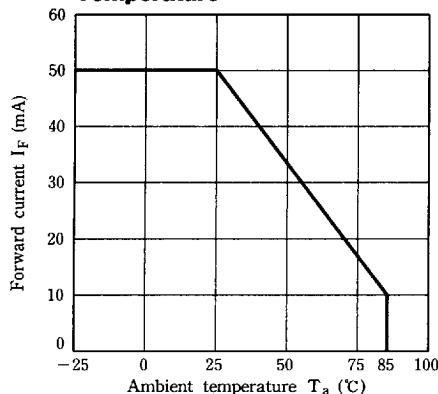
Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input	Forward voltage	V <sub>F</sub>	I <sub>F</sub> =4mA I <sub>F</sub> =0.3mA	— 0.7	1.1 1.0	1.4 —	V
	Reverse current	I <sub>R</sub>	Ta=25°C, V <sub>R</sub> =3V	—	—	10	μA
	Terminal capacitance	C <sub>t</sub>	Ta=25°C, V=0, f=1kHz	—	30	250	pF
Output	Operating supply voltage	V <sub>CC</sub>		3	—	15	V
	Low level output voltage	V <sub>OL</sub>	I <sub>OL</sub> =16mA, V <sub>CC</sub> =5V, I <sub>F</sub> =4mA	—	0.2	0.4	V
	High level output current	I <sub>OH</sub>	V <sub>O</sub> =V <sub>CC</sub> =15V, I <sub>F</sub> =0	—	—	100	μA
	Low level supply current	I <sub>CCL</sub>	V <sub>CC</sub> =5V, I <sub>F</sub> =4mA	—	2.5	5.0	mA
Transfer characteristics	High level supply current	I <sub>CH</sub>	V <sub>CC</sub> =5V, I <sub>F</sub> =0	—	1.0	5.0	mA
	* "High→Low" threshold input current	I <sub>FHL</sub>	Ta=25°C, V <sub>CC</sub> =5V, R <sub>L</sub> =280Ω V <sub>CC</sub> =5V, R <sub>L</sub> =280Ω	— —	1.1 —	2.0 4.0	mA
	* "Low→High" threshold input current	I <sub>FLH</sub>	Ta=25°C, V <sub>CC</sub> =5V, R <sub>L</sub> =280Ω V <sub>CC</sub> =5V, R <sub>L</sub> =280Ω	0.4 0.3	0.8 —	— —	mA
	Hysteresis	I <sub>FLH</sub> /I <sub>FHL</sub>	V <sub>CC</sub> =5V, R <sub>L</sub> =280Ω	0.5	0.7	0.9	—
	Isolation resistance	R <sub>ISO</sub>	Ta=25°C, DC500V, 40 to 60% RH	5×10 <sup>10</sup>	10 <sup>11</sup>	—	Ω
Response time	"High→Low" propagation delay time	t <sub>PHL</sub>	Ta=25°C V <sub>CC</sub> =5V, I <sub>F</sub> =4mA R <sub>L</sub> =280Ω	—	1	3	μs
	"Low→High" propagation delay time	t <sub>PLH</sub>		—	2	6	
	Fall time	t <sub>f</sub>		—	0.05	0.5	
	Rise time	t <sub>r</sub>		—	0.1	0.5	

\*4 I<sub>FHL</sub> represents forward current when output goes from high to low.\*5 I<sub>FLH</sub> represents forward current when output goes from low to high.\*6 Hysteresis stands for I<sub>FLH</sub>/I<sub>FHL</sub>.

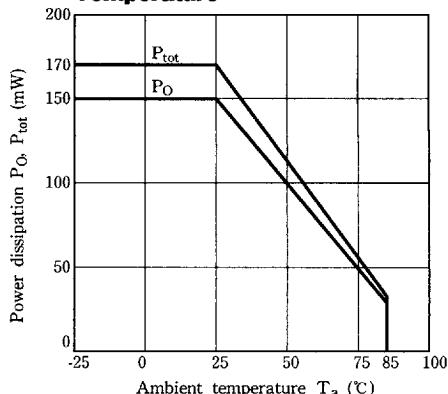
\*7 Test circuit for response time is shown below.

**(Precautions for Use)**Connect a capacitor of more than 0.1 μF between V<sub>CC</sub> and GND.**Test Circuit for Response Time**

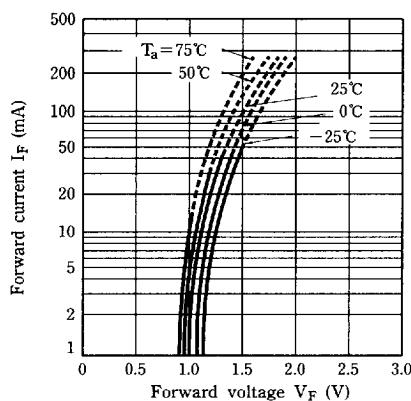
**Fig. 1 Forward Current vs. Ambient Temperature**



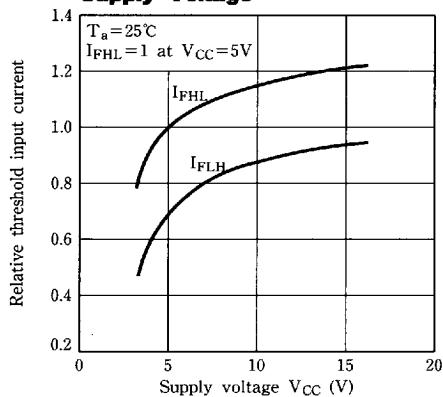
**Fig. 2 Power Dissipation vs. Ambient Temperature**



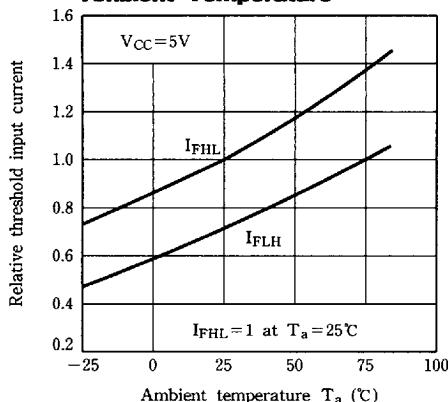
**Fig. 3 Forward Current vs. Forward Voltage**



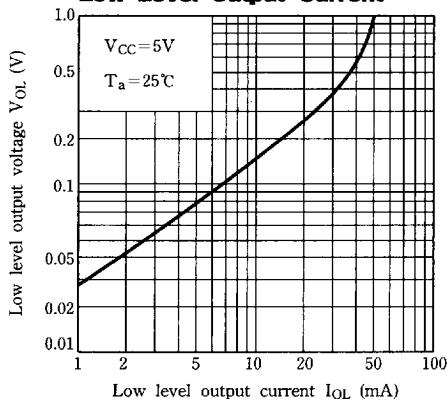
**Fig. 4 Relative Threshold Input Current vs. Supply Voltage**



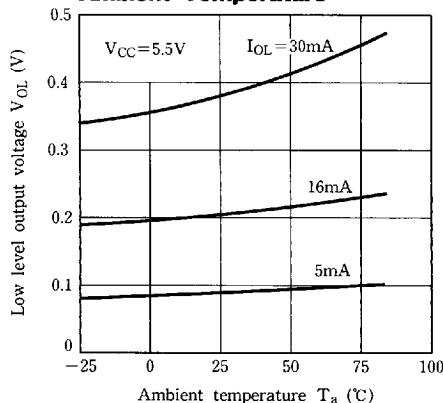
**Fig. 5 Relative Threshold Input Current vs. Ambient Temperature**



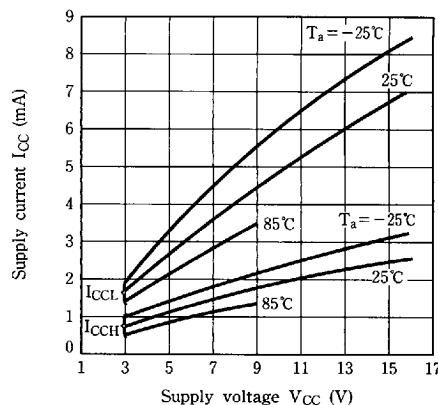
**Fig. 6 Low Level Output Voltage vs. Low Level Output Current**



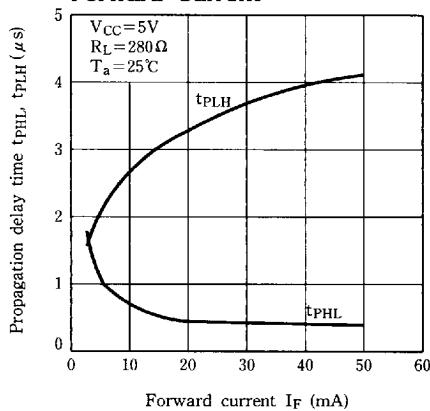
**Fig. 7 Low Level Output Voltage vs. Ambient Temperature**



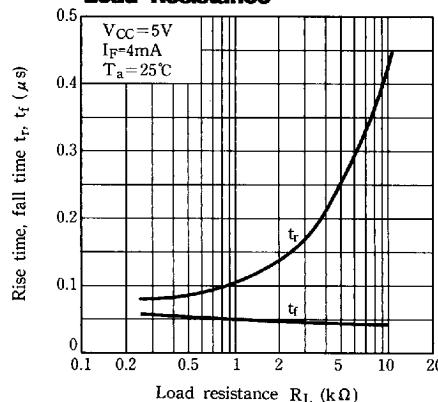
**Fig. 8 Supply Current vs. Supply Voltage**



**Fig. 9 Propagation Delay Time vs. Forward Current**



**Fig. 10 Rise Time, Fall Time vs. Load Resistance**



## ■ Precautions for Use

- (1) It is recommended that a by-pass capacitor of more than  $0.01 \mu\text{F}$  is added between  $\text{V}_{\text{CC}}$  and GND near the device in order to stabilize power supply line.
- (2) Handle this product the same as with other integrated circuits against static electricity.
  - Please refrain from soldering under preheating and refrain from soldering by reflow.
- Please refer to the chapter "Precautions for Use." (Page 78 to 93).